Notice of References Cited Application/Control No. Applicant(s)/Patent Under Reexamination EITAKI, SHU Examiner Art Unit Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,530,198 A	06-1996	Ishii, Jun	84/21
*	В	US-5,583,310 A	12-1996	Sugiyama et al.	84/719
*	С	US-5,627,333 A	05-1997	Stahnke et al.	84/462
*	D	US-5,648,621 A	07-1997	Sasaki, Tomoya	84/171
*	Е	US-5,650,580 A	07-1997	Yamamoto et al.	84/21
*	F	US-5,714,702 A	02-1998	Ishii, Jun	84/462
*	G	US-5,739,450 A	04-1998	Fujiwara et al.	84/462
*	н	US-6,051,762 ⁻ A	04-2000	Fujiwara et al.	84/21
*	ı	US-6,075,196 A	06-2000	Fujiwara et al.	84/645
*	J	US-6,229,081 B1	05-2001	Ura et al.	84/462
*	κ	US-2001/0007221 A1	07-2001	Uehara, Haruki	84/649
*	L	US-6,271,447 B1	08-2001	Fujiwara et al.	84/21
*	М	US-6,297,437 B1	10-2001	Ura et al.	84/423R

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

Application/Control No.

10/589,856

Examiner

David S. Warren

Applicant(s)/Patent Under Reexamination EITAKI, SHU

Art Unit
Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,359,207 B1	03-2002	Oba et al.	84/658
*	В	US-6,417,439 B2	07-2002	Uehara et al.	84/645
*	С	US-6,472,589 B1	10-2002	Lee, Charles R.	84/21
*	D	US-2002/0178898 A1	12-2002	Hagiwara et al.	84/664
*	E	US-6,737,571 B2	05-2004	Furukawa, Rei	84/610
*	F	US-6,750,389 B2	06-2004	Hagiwara et al.	84/631
*	G	US-2005/0145104 A1	07-2005	Sasaki, Tsutomu	[′] 084/746
*	Н	US-2005/0235808 A1	10-2005	Ishii et al.	084/600
*	1	US-2006/0130640 A1	06-2006	Fujiwara, Yuji	084/626
*	J	US-2006/0196346 A1	09-2006	Ohba et al.	084/616
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.